## **AMENDMENTS TO THE CLAIMS**

1-2. (Cancelled)

3. (Original) A single crystal substrate comprising:

a langasite substrate with a SAW propagation surface; and

input and output IDTs having electrodes on the surface for launching and/or detecting

surface acoustic waves, wherein a direction of surface wave propagation is parallel to an X'-axis,

and the substrate further has an Z'-axis perpendicular to the surface and a Y'-axis parallel to the

surface and perpendicular to the X'-axis, the langasite substrate having a crystal orientation

defined by modified axes X, Y and Z, the relative orientation of axes X', Y' and Z' being

defined by Euler angles  $\phi$ ,  $\theta$  and  $\psi$ , in which  $\phi$  is  $0^{\circ}$ ,  $\theta$  is in a range of  $12^{\circ} \le \theta \le 17^{\circ}$ , and  $\psi$  is in a

range of  $73^{\circ} \le \psi \le 78^{\circ}$ .

4. (Original) The single crystal substrate according to claim 3, wherein optimal Euler

angles of the langasite are  $\phi = 0^{\circ}$ ,  $\theta = 14.6^{\circ}$  and  $\psi = 76.2^{\circ}$ .

5. (Original) A single crystal substrate comprising:

a quartz substrate with a SAW propagation surface; and

input and output IDTs having electrodes on the surface for launching and/or detecting

surface acoustic waves, wherein a direction of surface wave propagation is parallel to an X'-axis,

and the substrate further has an Z'-axis perpendicular to the surface and a Y'-axis parallel to the

surface and perpendicular to the X'-axis, the quartz substrate having a crystal orientation defined

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by modified axes X, Y and Z, the relative orientation of axes X', Y' and Z' being defined by Euler angles  $\phi$ ,  $\theta$  and  $\psi$ , in which  $\phi$  is in a range of  $-5^{\circ} \le \phi \le +5^{\circ}$ ,  $\theta$  is in a range of  $60^{\circ} \le \theta \le 80^{\circ}$ 

and  $\psi$  is in a range of  $-5^{\circ} \le \psi \le +5^{\circ}$ .

6. (Original) The single crystal substrate according to claim 5, wherein optimal Euler

angles of the quartz are  $\phi = 0^{\circ}$ ,  $\theta = 70.5^{\circ}$  and  $\psi = 0^{\circ}$ .

7. (Original) A single crystal substrate comprising:

a quartz substrate with a SAW propagation surface; and

input and output IDTs having electrodes on the surface for launching and/or detecting surface acoustic waves, wherein a direction of surface wave propagation is parallel to an X'-axis, and the substrate further has an Z'-axis perpendicular to the surface and a Y'-axis parallel to the surface and perpendicular to the X'-axis, the quartz substrate having a crystal orientation defined by modified axes X, Y and Z, the relative orientation of axes X', Y' and Z' being defined by Euler angles  $\phi$ ,  $\theta$  and  $\psi$ , in which  $\phi$  is  $0^{\circ}$ ,  $\theta$  is in a range of  $17^{\circ} \le \theta \le 23^{\circ}$  and  $\psi$  is in a range of  $10^{\circ} \le \psi \le 20^{\circ}$ .

8. (Original) The single crystal substrate according to claim 7, wherein optimal Euler angles of the quartz are  $\phi = 0^{\circ}$ ,  $\theta = 20^{\circ}$  and  $\psi = 13.7^{\circ}$ .

9. (Original) A single crystal substrate comprising:

a lithium tantalate substrate with a SAW propagation surface; and

input and output IDTs having electrodes on the surface for launching and/or detecting surface acoustic waves, wherein a direction of surface wave propagation is parallel to an X'-axis, and the substrate further has an Z'-axis perpendicular to the surface and a Y'-axis parallel to the surface and perpendicular to the X'-axis, the lithium tantalate substrate having a crystal orientation defined by modified axes X, Y and Z, the relative orientation of axes X', Y' and Z' being defined by Euler angles  $\phi$ ,  $\theta$  and  $\psi$ , in which  $\phi$  is in a range of  $-5^{\circ} \le \phi \le +5^{\circ}$ ,  $\theta$  is in a range of  $70^{\circ} \le \theta \le 90^{\circ}$  and  $\psi$  is in a range of  $85^{\circ} \le \psi \le 95^{\circ}$ .

- 10. (Original) The single crystal substrate according to claim 9, wherein optimal Euler angles of the lithium tantalate are  $\phi = 0^{\circ}$ ,  $\theta = 79^{\circ}$  and  $\psi = 90^{\circ}$ .
  - 11. (Original) A single crystal substrate comprising:
  - a lithium tantalate substrate with a SAW propagation surface; and

input and output IDTs having electrodes on the surface for launching and/or detecting surface acoustic waves, wherein a direction of surface wave propagation is parallel to an X'-axis, and the substrate further has an Z'-axis perpendicular normal to the surface and a Y'-axis parallel to the surface and perpendicular to the X'-axis, the lithium tantalate substrate having a crystal orientation defined by modified axes X, Y and Z, the relative orientation of axes X', Y' and Z' being defined by Euler angles  $\phi$ ,  $\theta$  and  $\psi$ , in which  $\phi$  is in a range of  $-5^{\circ} \le \phi \le +5^{\circ}$ ,  $\theta$  is in a range of  $160^{\circ} \le \theta \le 180^{\circ}$  and  $\psi$  is in a range of  $85^{\circ} \le \psi \le 95^{\circ}$ .

12. (Original) The single crystal substrate according to claim 11, wherein optimal Euler angles of the lithium tantalate are  $\phi = 0^{\circ}$ ,  $\theta = 168^{\circ}$  and  $\psi = 90^{\circ}$ .

13. (Original) A single crystal substrate comprising:

a lithium tantalate substrate with a SAW propagation surface; and

input and output IDTs having electrodes on the surface for launching and/or detecting surface acoustic waves, wherein a direction of surface wave propagation is parallel to an X'-axis, and the substrate further has an Z'-axis perpendicular to the surface and a Y'-axis parallel to the surface and perpendicular to the X'-axis, the lithium tantalate substrate having a crystal orientation defined by modified axes X, Y and Z, the relative orientation of axes X', Y' and Z' being defined by Euler angles  $\phi$ ,  $\theta$  and  $\psi$ , in which  $\phi$  is in a range of  $-5^{\circ} \le \phi \le +5^{\circ}$ ,  $\theta$  is in a range of  $20^{\circ} \le \theta \le 40^{\circ}$  and  $\psi$  is in a range of  $5^{\circ} \le \psi \le 25^{\circ}$ .

14. (Original) The single crystal substrate according to claim 13, wherein optimal Euler angles of the lithium tantalate are  $\phi = 0^{\circ}$ ,  $\theta = 30^{\circ}$  and  $\psi = 16.5^{\circ}$ .

15-18. (Cancelled)

19. (New) A single crystal substrate comprising:

a langasite substrate with a SAW propagation surface; and

input and output IDTs having electrodes on the surface for launching and/or detecting surface acoustic waves, wherein a direction of surface wave propagation is parallel to an X'-axis, Birch, Stewart, Kolasch & Birch, LLP

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and the substrate further has an Z'-axis perpendicular to the surface and a Y'-axis parallel to the surface and perpendicular to the X'-axis, the langasite substrate having a crystal orientation defined by modified axes X, Y and Z, the relative orientation of axes X', Y' and Z' being defined by Euler angles  $\phi$ ,  $\theta$  and  $\psi$ , in which optimal Euler angles of the langasite are  $\phi = 10^{\circ}$ ,  $\theta$ = 23.6° and  $\psi$  = 78.8° such that a power flow angle and a first order temperature coefficient of delay are substantially zero (0).

- 20. (New) A cutting method of a single crystal substrate comprising the steps of:
- (a) defining a crystal orientation based on modified axes X, Y and Z, for the surface of the single crystal substrate which surface acoustic waves are propagated;
- (b) defining X', Y' and Z' axes on the single crystal substrate, in which a direction of surface wave of the propagation is parallel to X'-axis and the Z'-axis is perpendicular to the surface wave and the Y'-axis is parallel to the surface and normal to the X'-axis;
- (c) defining the X', Y' and Z' axes defined at (b) as relative orientation Euler angles of crystals,  $\phi$ ,  $\theta$  and  $\psi$ ; and
- (d) setting a range of the  $\phi$ ,  $\theta$ , and  $\psi$  defined at (c) in an optimal range in accordance with a type of the substrate, wherein the single crystal substrate is one of a langasite substrate, a quartz substrate and a lithium tantalite substrate,

when the single crystal substrate is the langasite substrate, selecting the range of the  $\phi$ ,  $\theta$ , and  $\psi$  to be either that  $\phi = 10^{\circ}$ ,  $\theta = 23.6^{\circ}$  and  $\psi = 78.8^{\circ}$  such that a power flow angle and a first order temperature coefficient of delay are substantially zero (0), or that  $\phi$  is  $0^{\circ}$ ,  $\theta$  is in a range of  $12^{\circ} \le \theta \le 17^{\circ}$ , and  $\psi$  is in a range of  $73^{\circ} \le \psi \le 78^{\circ}$ ;

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when the single crystal substrate is the quartz substrate, selecting the range of the  $\phi$ ,  $\theta$ , and  $\psi$  to be either that  $\phi$  is in a range of  $-5^{\circ} \le \phi \le +5^{\circ}$ ,  $\theta$  is in a range of  $60^{\circ} \le \theta \le 80^{\circ}$  and  $\psi$ is in a range of  $-5^{\circ} \le \psi \le +5^{\circ}$ , or that  $\phi$  is  $0^{\circ}$ ,  $\theta$  is in a range of  $17^{\circ} \le \theta \le 23^{\circ}$  and  $\psi$  is in a range of  $10^{\circ} \le \psi \le 20^{\circ}$ ;

when the single crystal substrate is the lithium tantalite substrate, selecting the range of the  $\phi$ ,  $\theta$ , and  $\psi$  to be either that  $\phi$  is in a range of  $-5^{\circ} \le \phi \le +5^{\circ}$ ,  $\theta$  is in a range of  $70^{\circ} \le \theta$  $\leq 90^{\circ}$  and  $\psi$  is in a range of  $85^{\circ} \leq \psi \leq 95^{\circ}$ , or that  $\phi$  is in a range of  $-5^{\circ} \leq \phi \leq +5^{\circ}$ ,  $\theta$  is in a range of  $160^{\circ} \le \theta \le 180^{\circ}$  and  $\psi$  is in a range of  $85^{\circ} \le \psi \le 95^{\circ}$ .

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